Notice of References Cit	ted
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Application/Control No. 10/560,427		Applicant(s)/Patent Under Reexamination YAMADA ET AL.		
	Examiner	Art Unit		
	Rvan Stronczer	2623	Page 1 of 1	

## U.S. PATENT DOCUMENTS

	Old First December 1				
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,204,662 A	04-1993	Oda et al.	340/825.25
*	В	US-5,666,363 A	09-1997	Osakabe et al.	370/426
*	С	US-2001/0014972 A1	08-2001	Shepherd, Nicoll B.	725/86
*	D	US-2001/0025376 A1	09-2001	Knobl, Karl-Heinz	725/74
*	Е	US-2002/0089427 A1	07-2002	Aratani et al.	340/825.72
*	F	US-2003/0066082 A1	04-2003	Kliger et al.	725/80
*	G	US-6,665,310 B1	12-2003	Nakatsugawa, Yoshinori	370/442
*	Н	US-2004/0049797 A1	03-2004	Salmonsen, Daniel R.	725/132
*	1	US-2004/0210630 A1	10-2004	Simonnet et al.	709/203
*	J	US-6,976,267 B1	12-2005	Takano et al.	725/80
*	к	US-7,150,032 B1	12-2006	Sadanaka et al.	725/80
*	L	US-7,200,855 B2	04-2007	Laksono, Indra	725/82
*	М	US-7,360,235 B2	04-2008	Davies et al.	725/133

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	т					

## NON-PATENT DOCUMENTS

_	NON-FAIENT DOCUMENTS						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	v						
	w						
	×						

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